Power MOSFET

30 V, 117 A, Single N-Channel, SO-8FL

Features

- Integrated Schottky Diode
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Para	meter		Symbol	Value	Unit
Drain-to-Source Vo	ltane		V _{DSS}	30	V
Gate-to-Source Vol			V _{GS}	+20	V
Continuous Drain	I	T _A = 25°C	I _D	22.5	A
Current R _{θJA} (Note 1)		T _A = 85°C	.0	16.2	,,
Power Dissipation R _{0JA} (Note 1)		T _A = 25°C	P _D	2.72	W
Continuous Drain		T _A = 25°C	I _D	36.7	Α
Current R _{θJA} ≤ 10 sec		T _A = 85°C		26.5	
Power Dissipation $R_{\theta JA,} t \leq 10 \text{ sec}$	Steady	T _A = 25°C	P _D	7.23	W
Continuous Drain	State	T _A = 25°C	I _D	13.2	Α
Current R _{θJA} (Note 2)		T _A = 85°C		9.5	
Power Dissipation R _{θJA} (Note 2)		T _A = 25°C	P _D	0.93	W
Continuous Drain		T _C = 25°C	I _D	117	Α
Current R _{θJC} (Note 1)		T _C = 85°C		84.4	
Power Dissipation R ₀ JC (Note 1)		T _C = 25°C	P _D	73.5	W
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	234	Α
Current limited by pa	ckage	T _A = 25°C	I _{Dmaxpkg}	100	Α
Operating Junction a Temperature	ınd Storage		T _J , T _{STG}	-55 to +150	°C
Source Current (Bod	ly Diode)		I _S	92	Α
Drain to Source dV/dt		dV/dt	6	V/ns	
Single Pulse Drain-to-Source Avalanche Energy (V_{DD} = 50 V, V_{GS} = 10 V, I_L = 39 A_{pk} , L = 0.3 mH, R_G = 25 Ω)			EAS	228	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

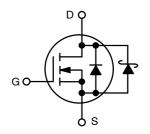


ON Semiconductor®

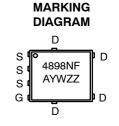
http://onsemi.com

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX	
30 V	3.0 mΩ @ 10 V	117 A	
	4.8 mΩ @ 4.5 V		

N-CHANNEL MOSFET







A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4898NFT1G	SO-8FL (Pb-Free)	1500 / Tape & Reel
NTMFS4898NFT3G	SO-8FL (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	1.7	
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	46	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	134.2	C/VV
Junction-to-Ambient - t ≤ 10 sec	$R_{ heta JA}$	17.3	

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

FI FCTRICAL CHARACTERISTICS (T = 25°C unless otherwise specified)

Parameter	Symbol	Test Cond	lition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•				1	1	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 1.0 mA		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				26		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	T _J = 25 °C		40	500	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	_S = ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 1.0 mA	1.5		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		2.2	3.0	
			I _D = 15 A		2.2		
		V _{GS} = 4.5 V	I _D = 30 A		3.4	4.8	mΩ
			I _D = 15 A		3.4		
Forward Transconductance	9FS	V _{DS} = 1.5 V,	_D = 15 A		77		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}				3233		
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 12 V			700		pF
Reverse Transfer Capacitance	C _{RSS}				310		
Total Gate Charge	Q _{G(TOT)}				24.5		
Threshold Gate Charge	Q _{G(TH)}	\/ 45\/\/	45 \		3.2		0
Gate-to-Source Charge	Q_{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} =$	15 V; I _D = 30 A		10		nC
Gate-to-Drain Charge	Q_{GD}				9		1
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _I I _D = 30	_{OS} = 15 V, OA		49.5		nC
SWITCHING CHARACTERISTICS (Note 4)	-			-	-	-	-
Turn-On Delay Time	t _{d(ON)}				17.6		
Rise Time	t _r	V_{GS} = 4.5 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			23		1
Turn-Off Delay Time	t _{d(OFF)}				28		ns
Fall Time	t _f				8.3		1

- 3. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.
- 4. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	ote 4)						
Turn-On Delay Time	t _{d(ON)}				11.3		
Rise Time	t _r	V _{GS} = 10 V, V _{DS} = 15 V,			17.8		
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 15 A, R_G$	$_{\rm i}$ = 3.0 Ω		37.3		ns
Fall Time	t _f				5.6		1
DRAIN-SOURCE DIODE CHARACT	ERISTICS						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	T _J = 25°C		0.38	0.70	
	1,	$I_{S} = 2.0 \text{ A}$	T _J = 125°C		0.31		
Reverse Recovery Time	t _{RR}		•		26.7		
Charge Time	t _a	$V_{GS} = 0 \text{ V, dI}_{S}/\text{dt} = 100 \text{ A}/\mu\text{s,}$ $I_{S} = 30 \text{ A}$			13.7		ns
Discharge Time	t _b				13.0		
Reverse Recovery Charge	Q _{RR}				17.3		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S				0.65		nH
Drain Inductance	L _D	T _A = 25°C			0.20		
Gate Inductance	L _G				1.5		
Gate Resistance	R_{G}				1.4		Ω

^{3.} Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

TYPICAL CHARACTERISTICS

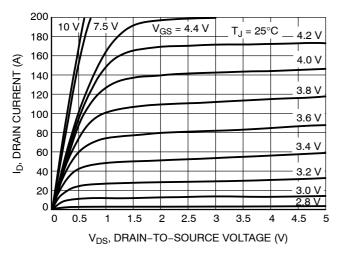


Figure 1. On-Region Characteristics

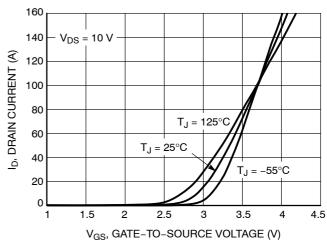


Figure 2. Transfer Characteristics

^{4.} Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

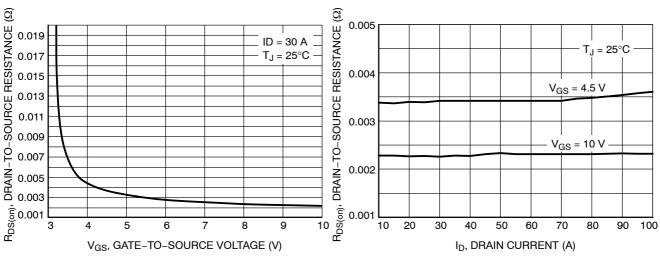


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On–Resistance vs. Drain Current and Gate Voltage

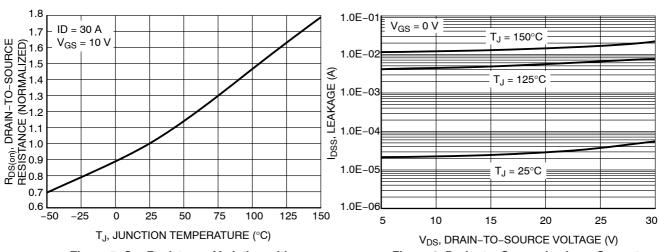


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

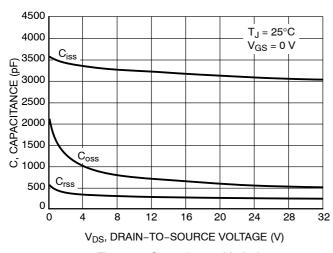


Figure 7. Capacitance Variation

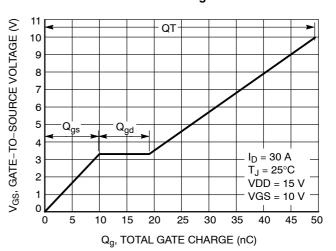


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

TYPICAL CHARACTERISTICS

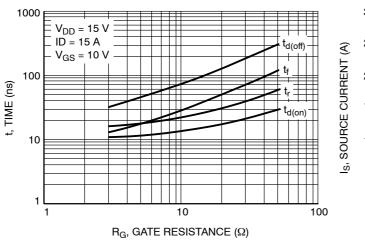


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

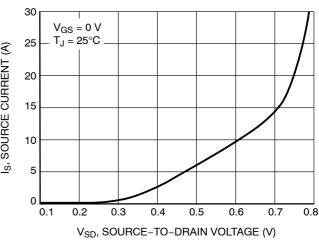


Figure 10. Diode Forward Voltage vs. Current

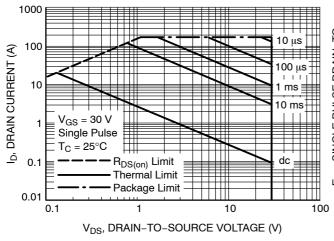


Figure 11. Maximum Rated Forward Biased Safe Operating Area

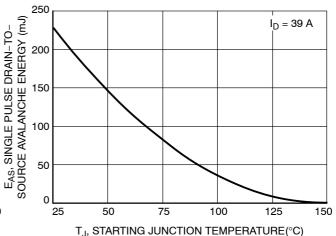


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

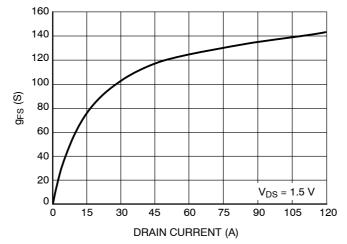


Figure 13. g_{FS} vs. Drain Current





DFN5 5x6, 1.27P (SO-8FL) CASE 488AA **ISSUE N**

DATE 25 JUN 2018

NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: MILLIMETER.
 3. DIMENSION D1 AND E1 DO NOT INCLUDE
- MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS				
DIM	MIN NOM MAX				
Α	0.90	1.00	1.10		
A1	0.00		0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D	5.00	5.15	5.30		
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E	6.00	6.15	6.30		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е		1.27 BSC	;		
G	0.51	0.575	0.71		
K	1.20	1.35	1.50		
L	0.51	0.575	0.71		
L1	0.125 REF				
М	3.00	3.40 3.8			
θ	0 °		12 °		

GENERIC MARKING DIAGRAM*



XXXXXX = Specific Device Code

= Assembly Location Α

Υ = Year W = Work Week ZZ = Lot Traceability

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





DETAIL A

SIDE VIEW

*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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ſ	DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1	

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